

<b>Notice of References Cited</b>	Application/Control No. 10/528,997	Applicant(s)/Patent Under Reexamination YAOI ET AL.	
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*	B	US-5,740,109	04-1998	Morton et al.	365/185.18
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*	D	US-6,141,262	10-2000	Sudo, Naoaki	365/189.09
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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